TEXAS INSTRUMENTS

TCA9548A-Q1

ZHCSJQ8A – MAY 2019 – REVISED NOVEMBER 2019

支持复位的 **TCA9548A-Q1** 汽车 **8** 通道 I²C 开关

1 特性

- 符合面向汽车应用的 AEC-Q100 应用的 16 通道 AFE：
  - 温度等级 3：-40℃ 至 +85℃，T_A
- 1 至 8 个双向转换开关
- 与 I²C 总线和 SMBus 兼容
- 低电平有效复位输入
- 三个地址引脚，I²C 总线最多支持八个 TCA9548A-Q1 器件
- 通过 I²C 总线进行通道选择，可任意组合
- 加电时所有开关通道取消选定
- 低 R_{ON} 开关
- 支持在 1.8V、2.5V、3.3V 和 5V 总线间进行电压电平转换
- 加电时无干扰
- 支持热插入
- 低静态电流
- 工作电源电压范围为 1.65V 至 5.25V
- 5V 耐压输入
- 0 至 400kHz 时钟频率
- 闩锁性能超过 100mA，符合 JESD 78 II 类规范

2 应用

- 信息娱乐系统
- 车身和控制
- 路由器（电信交换设备）
- 工厂自动化
- 具有 I²C 从器件地址冲突（例如，多个完全一样的温度传感器）的产品

3 说明

TCA9548A-Q1 器件配有八个可通过 I²C 总线控制的双向转换开关。串行时钟/串行数据 (SCL/SDA) 上行对可扩展为 8 个下行对或通道。根据可编程控制寄存器的内容，可选择任一单独 SCn/SDn 通道或者通道组合。这些下游通道可用于解决 I²C 从器件地址冲突。例如，如果应用中需要八个完全相同的数字温度传感器，则每个通道 (0-7) 可以连接一个传感器。

发生超时或其他不当操作时，系统主控器可通过将 $\overline{RESET}$ 输入置为低电平来复位 TCA9548A-Q1。同样，加电复位即可取消选中所有通道并初始化 I²C/SMBus 状态机。将 $\overline{RESET}$ 置为有效也可实现复位和初始化，并且无需将部件断电。这样可以在下游 I²C 总线之一卡在低电平状态时进行恢复。
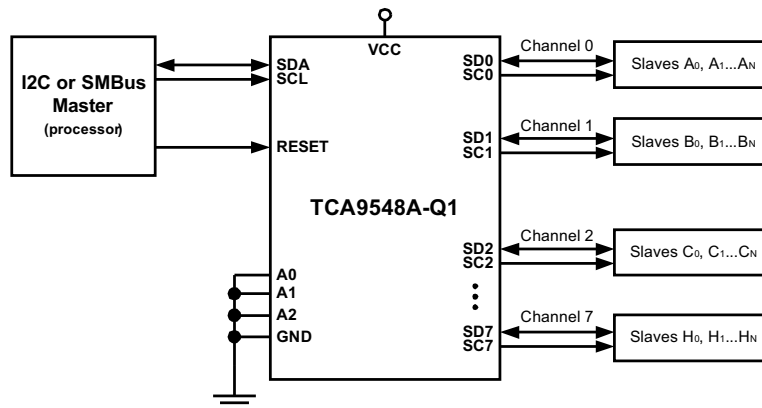
由于在开关上有导通栅极，因此可使用 VCC 引脚来限制 TCA9548A-Q1 传递的最大高电压。限制最大高电压后，可以在每个对上使用不同的总线电压，从而让 1.8V、2.5V 或 3.3V 部件能够在没有任何额外保护的情况下与 5V 部件通信。对于每个通道，外部上拉电阻器将总线电压上拉至所需的电压水平。所有 I/O 引脚均可承受 5V 电压。

器件信息[1]

器件型号	封装	封装尺寸（标称值）
TCA9548A-Q1	VQFN (24)	4.00mm × 4.00mm

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。

简化应用示意图

目录

4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

Changes from Original (May 2019) to Revision A	**Page**
• V_{CC} value missing, added V_{CC} = 2.5 V in 图 12.. 20	

5 Pin Configuration and Functions

RGE Package
24-Pin VQFN
Top View

Not to scale
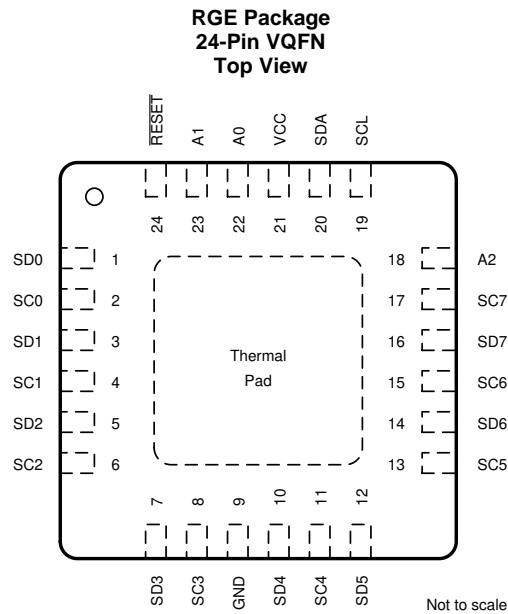
Pin Functions

PIN		TYPE	DESCRIPTION
NAME	QFN (RGE)		
A0	22	I	Address input 0. Connect directly to V_{CC} or ground
A1	23	I	Address input 1. Connect directly to V_{CC} or ground
A2	18	I	Address input 2. Connect directly to V_{CC} or ground
GND	9	—	Ground
$\overline{RESET}$	24	I	Active-low reset input. Connect to V_{CC} or V_{DPUM}[1] through a pull-up resistor, if not used
SD0	1	I/O	Serial data 0. Connect to V_{DPU0}[1] through a pull-up resistor
SC0	2	I/O	Serial clock 0. Connect to V_{DPU0}[1] through a pull-up resistor
SD1	3	I/O	Serial data 1. Connect to V_{DPU1}[1] through a pull-up resistor
SC1	4	I/O	Serial clock 1. Connect to V_{DPU1}[1] through a pull-up resistor
SD2	5	I/O	Serial data 2. Connect to V_{DPU2}[1] through a pull-up resistor
SC2	6	I/O	Serial clock 2. Connect to V_{DPU2}[1] through a pull-up resistor
SD3	7	I/O	Serial data 3. Connect to V_{DPU3}[1] through a pull-up resistor
SC3	8	I/O	Serial clock 3. Connect to V_{DPU3}[1] through a pull-up resistor
SD4	10	I/O	Serial data 4. Connect to V_{DPU4}[1] through a pull-up resistor
SC4	11	I/O	Serial clock 4. Connect to V_{DPU4}[1] through a pull-up resistor
SD5	12	I/O	Serial data 5. Connect to V_{DPU5}[1] through a pull-up resistor
SC5	13	I/O	Serial clock 5. Connect to V_{DPU5}[1] through a pull-up resistor
SD6	14	I/O	Serial data 6. Connect to V_{DPU6}[1] through a pull-up resistor
SC6	15	I/O	Serial clock 6. Connect to V_{DPU6}[1] through a pull-up resistor
SD7	16	I/O	Serial data 7. Connect to V_{DPU7}[1] through a pull-up resistor
SC7	17	I/O	Serial clock 7. Connect to V_{DPU7}[1] through a pull-up resistor
SCL	19	I/O	Serial clock bus. Connect to V_{DPUM}[1] through a pull-up resistor
SDA	20	I/O	Serial data bus. Connect to V_{DPUM}[1] through a pull-up resistor
VCC	21	Power	Supply voltage

(1) V_{DPUX} is the pull-up reference voltage for the associated data line. V_{DPUM} is the master I²C reference voltage and V_{DPU0}-V_{DPU7} are the slave channel reference voltages.

6 Specifications

6.1 Absolute Maximum Ratings[1]

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	Supply voltage		−0.5	7	V
V_I	Input voltage[2]		−0.5	7	V
I_I	Input current		−20	20	mA
I_O	Output current		−25		mA
I_{CC}	Supply current		−100	100	mA
T_{stg}	Storage temperature		−65	150	°C
T_J	Max Junction Temperature	V_{CC} ≤ 5.25 V		90	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per AEC Q100-002[1] HBM ESD Classification Level 2	±2000	V
		Charged-device model (CDM), per AEC Q100-011 CDM ESD Classification Level C6	±1000	

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

			MIN	MAX	UNIT
V_{CC}	Supply voltage	-40 °C ≤ T_A ≤ 85 °C	1.65	5.25	V
V_{IH}	High-level input voltage	SCL, SDA	0.7 × V_{CC}	6	V
		A2–A0, $\overline{RESET}$	0.7 × V_{CC}	V_{CC} + 0.5	
V_{IL}	Low-level input voltage	SCL, SDA	−0.5	0.3 × V_{CC}	V
		A2–A0, $\overline{RESET}$	−0.5	0.3 × V_{CC}	
T_A	Operating free-air temperature	1.65 V ≤ V_{CC} ≤ 5.25 V	−40	85	°C

6.4 Thermal Information

	THERMAL METRIC[1]	TCA9548A	UNIT
		RGE (VQFN)	
		24 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	57.2	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	62.5	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	34.4	°C/W
ψ_{JT}	Junction-to-top characterization parameter	3.8	°C/W
ψ_{JB}	Junction-to-board characterization parameter	34.4	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	15.5	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.

6.5 Electrical Characteristics[1]

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS	V_{CC}	MIN	TYP	MAX	UNIT
V_{PORR}	Power-on reset voltage, V_{CC} rising		No load, V_I = V_{CC} or GND[2]			1.2	1.5	V
V_{PORF}	Power-on reset voltage, V_{CC} falling[3]		No load, V_I = V_{CC} or GND[2]		0.8	1		V
$V_{o(sw)}$	Switch output voltage		$V_{i(sw)}$ = V_{CC}, I_{SWout} = −100 µA	5 V		3.6		V
				4.5 V to 5.25 V	2.6		4.5	
				3.3 V		1.9		
				3 V to 3.6 V	1.6		2.8	
				2.5 V		1.5		
				2.3 V to 2.7 V	1.1		2	
				1.8 V		1.1		
				1.65 V to 1.95 V	0.6		1.25	
I_{OL}	SDA		V_{OL} = 0.4 V	1.65 V to 5.25 V	3	6		mA
			V_{OL} = 0.6 V		5	9		
I_I	SCL, SDA		V_I = V_{CC} or GND[2]	1.65 V to 5.25 V	−1		1	µA
	SC7–SC0, SD7–SD0				−1		1	
	A2–A0				−1		1	
	$\overline{RESET}$				−1		1	
I_{CC}	Operating mode	f_{SCL} = 400 kHz	V_I = V_{CC} or GND[2], I_O = 0	5.25 V		50	80	µA
				3.6 V		20	35	
				2.7 V		11	20	
				1.65 V		6	10	
		f_{SCL} = 100 kHz	V_I = V_{CC} or GND[2], I_O = 0	5.25 V		9	30	
				3.6 V		6	15	
				2.7 V		4	8	
				1.65 V		2	4	
	Standby mode	Low inputs	V_I = GND[2], I_O = 0	5.25 V		0.2	4	
				3.6 V		0.1	2	
				2.7 V		0.1	2	
				1.65 V		0.1	1	
		High inputs	V_I = V_{CC}, I_O = 0	5.25 V		0.2	4	
				3.6 V		0.1	2	
				2.7 V		0.1	2	
				1.65 V		0.1	1	
ΔI_{CC}	Supply-current change	SCL, SDA	SCL or SDA input at 0.6 V, Other inputs at V_{CC} or GND[2]	1.65 V to 5.25 V		3	20	µA
			SCL or SDA input at V_{CC} − 0.6 V, Other inputs at V_{CC} or GND[2]			3	20	
C_i	A2–A0		V_I = V_{CC} or GND[2]	1.65 V to 5.25 V		4	5	pF
	$\overline{RESET}$					4	5	
	SCL		V_I = V_{CC} or GND[2], Switch OFF			20	28	
$C_{io(off)}$[4]	SDA		V_I = V_{CC} or GND[2], Switch OFF	1.65 V to 5.25 V		20	28	pF
	SC7–SC0, SD7–SD0					5.5	7.5	
R_{ON}	Switch-on resistance		V_O = 0.4 V, I_O = 15 mA	4.5 V to 5.25 V	4	10	25	Ω
				3 V to 3.6 V	5	12	35	
			V_O = 0.4 V, I_O = 10 mA	2.3 V to 2.7 V	7	15	45	
				1.65 V to 1.95 V	10	25	70	

(1) For operation between specified voltage ranges, refer to the worst-case parameter in both applicable ranges.
(2) $\overline{RESET}$ = V_{CC} (held high) when all other input voltages, V_I = GND.
(3) The power-on reset circuit resets the I²C bus logic with V_{CC} < V_{PORF}.
(4) $C_{io(ON)}$ depends on internal capacitance and external capacitance added to the SCn lines when channels(s) are ON.

6.6 I²C InterfaceTiming Requirements

over recommended operating free-air temperature range (unless otherwise noted) (see 图 4)

			MIN	MAX	UNIT
STANDARD MODE					
f_{scl}	I²C clock frequency		0	100	kHz
t_{sch}	I²C clock high time		4		µs
t_{scl}	I²C clock low time		4.7		µs
t_{sp}	I²C spike time			50	ns
t_{sds}	I²C serial-data setup time		250		ns
t_{sdh}	I²C serial-data hold time		0[1]		µs
t_{icr}	I²C input rise time			1000	ns
t_{icf}	I²C input fall time			300	ns
t_{ocf}	I²C output (SDn) fall time (10-pF to 400-pF bus)			300	ns
t_{buf}	I²C bus free time between stop and start		4.7		µs
t_{sts}	I²C start or repeated start condition setup		4.7		µs
t_{sth}	I²C start or repeated start condition hold		4		µs
t_{sps}	I²C stop condition setup		4		µs
$t_{vdL(Data)}$	Valid-data time (high to low)[2]	SCL low to SDA output low valid		1	µs
$t_{vdH(Data)}$	Valid-data time (low to high)[2]	SCL low to SDA output high valid		0.6	µs
$t_{vd(ack)}$	Valid-data time of ACK condition	ACK signal from SCL low to SDA output low		1	µs
C_b	I²C bus capacitive load			400	pF
FAST MODE					
f_{scl}	I²C clock frequency		0	400	kHz
t_{sch}	I²C clock high time		0.6		µs
t_{scl}	I²C clock low time		1.3		µs
t_{sp}	I²C spike time			50	ns
t_{sds}	I²C serial-data setup time		100		ns
t_{sdh}	I²C serial-data hold time		0[1]		µs
t_{icr}	I²C input rise time		20	300	ns
t_{icf}	I²C input fall time		$20 \times (V_{CC} / 5.5\ V)$	300	ns
t_{ocf}	I²C output (SDn) fall time (10-pF to 400-pF bus)		$20 \times (V_{CC} / 5.5\ V)$	300	ns
t_{buf}	I²C bus free time between stop and start		1.3		µs
t_{sts}	I²C start or repeated start condition setup		0.6		µs
t_{sth}	I²C start or repeated start condition hold		0.6		µs
t_{sps}	I²C stop condition setup		0.6		µs
$t_{vdL(Data)}$	Valid-data time (high to low)[2]	SCL low to SDA output low valid		1	µs
$t_{vdH(Data)}$	Valid-data time (low to high)[2]	SCL low to SDA output high valid		0.6	µs
$t_{vd(ack)}$	Valid-data time of ACK condition	ACK signal from SCL low to SDA output low		1	µs
C_b	I²C bus capacitive load			400	pF

(1) A device internally must provide a hold time of at least 300 ns for the SDA signal (referred to the V_{IH} min of the SCL signal), to bridge the undefined region of the falling edge of SCL.
(2) Data taken using a 1-kΩ pull-up resistor and 50-pF load (see 图 5)

6.7 Reset Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	MIN	MAX	UNIT
$t_{W(L)}$	Pulse duration, $\overline{RESET}$ low	6		ns
$t_{REC(STA)}$	Recovery time from $\overline{RESET}$ to start	0		ns

6.8 Switching Characteristics

over recommended operating free-air temperature range, C_L ≤100 pF (unless otherwise noted) (see 图 4)

PARAMETER			FROM (INPUT)	TO (OUTPUT)	MIN	MAX	UNIT
t_{pd}[1]	Propagation delay time	R_{ON} = 20 Ω, C_L = 15 pF	SDA or SCL	SDn or SCn		0.3	ns
		R_{ON} = 20 Ω, C_L = 50 pF				1	
t_{rst}[2]	$\overline{RESET}$ time (SDA clear)		$\overline{RESET}$	SDA		500	ns

(1) The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by anideal voltage source (zero output impedance).

(2) t_{rst} is the propagation delay measured from the time the $\overline{RESET}$ pin is first asserted low to the time the SDA pin is asserted high, signaling a stop condition. It must be a minimum of t_{WL}.

6.9 Typical Characteristics
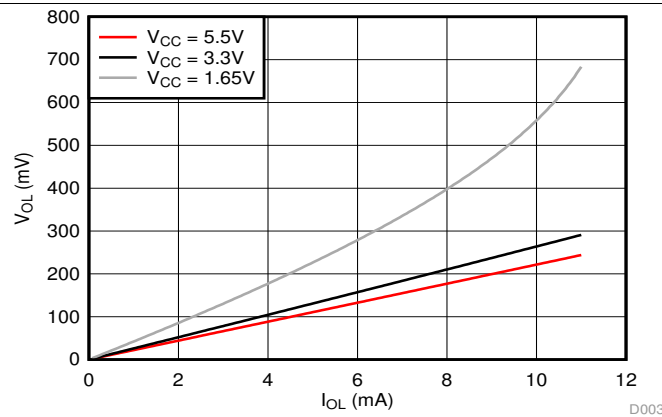
图 1. SDA Output Low Voltage (V$_{OL}$) vs Load Current (I$_{OL}$) at Three V$_{CC}$ Levels
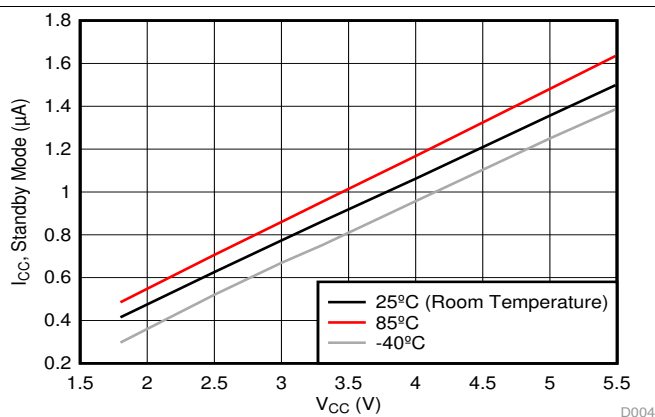
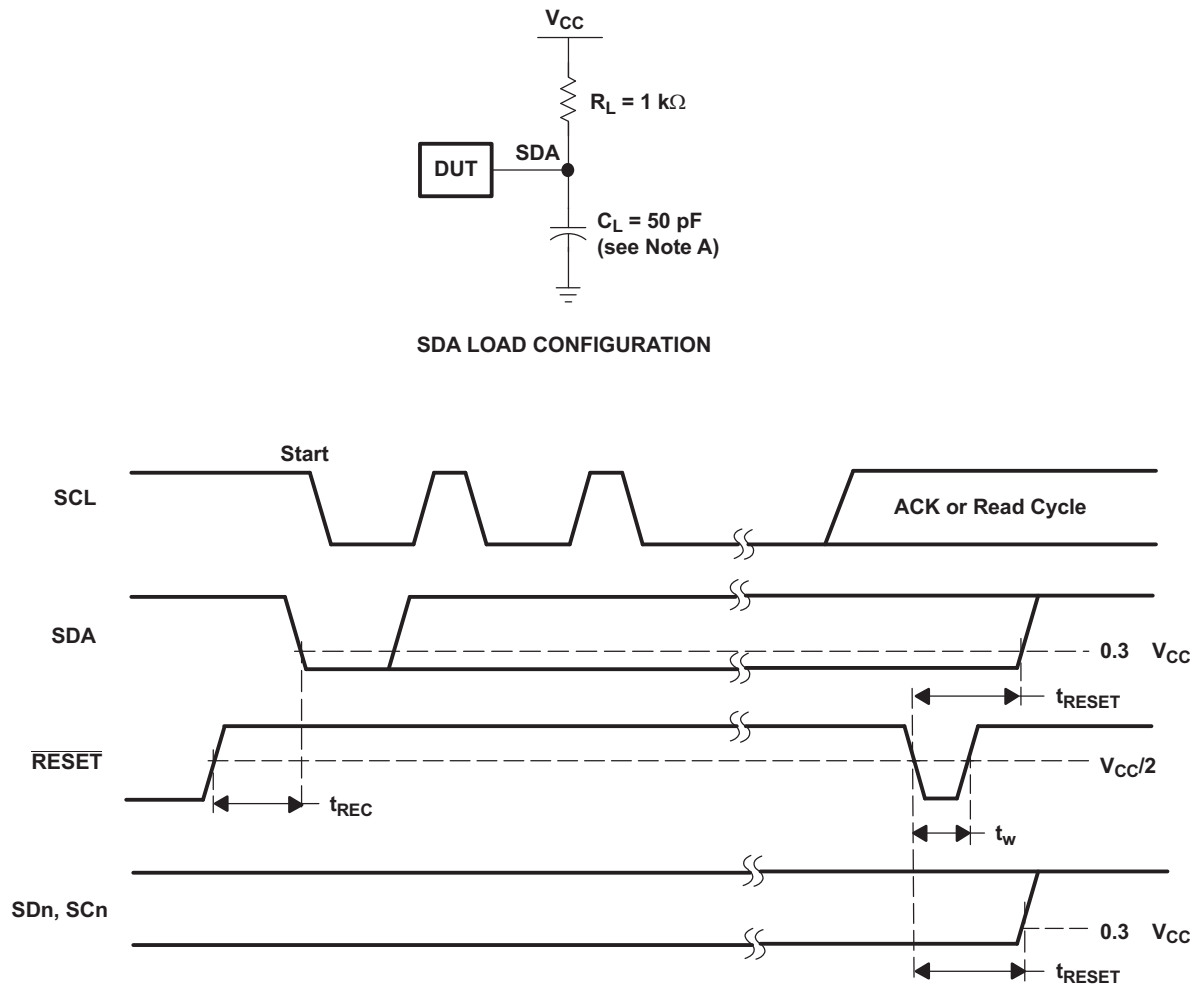图 2. Standby Current (I$_{CC}$) vs Supply Voltage (V$_{CC}$) at three temperatures
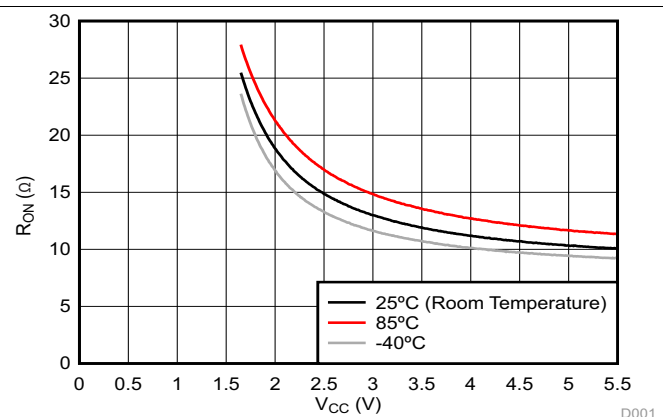
图 3. On-Resistance (R$_{ON}$) vs Supply Voltage (V$_{CC}$) at three temperatures

7 Parameter Measurement Information

V_{cc}

R_L = 1 kΩ

DUT — SDA

C_L = 50 pF
(see Note A)

SDA LOAD CONFIGURATION

Three Bytes for Complete Device Programming

| Stop Condition (P) | Start Condition (S) | Address Bit 7 (MSB) | Address Bit 6 | • • • | Address Bit 1 | R/W̄ Bit 0 (LSB) | ACK (A) | Data Bit 7 (MSB) | • • • | Data Bit 0 (LSB) | Stop Condition (P) |

SCL

t_{scl} t_{sch}
t_{icr} t_{icf}

$0.7 \times V_{cc}$
$0.3 \times V_{cc}$

$t_{vd(ack)}$ t_{sts}

SDA

t_{buf}
t_{icf} t_{icr} t_{sds} t_{sdh}
t_{sth}

t_{sp}
$t_{vdH(Data)}$
$t_{vdL(Data)}$ t_{sps}

$0.7 \times V_{cc}$
$0.3 \times V_{cc}$

Start or Repeat Start Condition

Repeat Start Condition

Stop Condition

VOLTAGE WAVEFORMS

BYTE	DESCRIPTION
1	I²C address
2, 3	P-port data

A. C_L includes probe and jig capacitance.

B. All inputs are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_r/t_f ≤ 30 ns.

C. Not all parameters and waveforms are applicable to all devices.

图 4. I²C Load Circuit and Voltage Waveforms

Parameter Measurement Information **(接下页)**

SDA LOAD CONFIGURATION

A. C_L includes probe and jig capacitance.

B.   All inputs are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_r/t_f ≤ 30 ns.

C.   I/Os are configured as inputs.

D.   Not all parameters and waveforms are applicable to all devices.

图 5. Reset Load Circuit and Voltage Waveforms

8 Detailed Description

8.1 Overview

The TCA9548A-Q1 is an 8-channel, bidirectional translating I^{2}C switch. The master SCL/SDA signal pair is directed to eight channels of slave devices, SC0/SD0-SC7/SD7. Any individual downstream channel can be selected as well as any combination of the eight channels.

The device offers an active-low $\overline{\text{RESET}}$ input which resets the state machine and allows the TCA9548A-Q1 to recover if one of the downstream I^{2}C buses get stuck in a low state. The state machine of the device can also be reset by cycling the power supply, V_{CC}, also known as a power-on reset (POR). Both the $\overline{\text{RESET}}$ function and a POR cause all channels to be deselected.

The connections of the I^{2}C data path are controlled by the same I^{2}C master device that is switched to communicate with multiple I^{2}C slaves. After the successful acknowledgment of the slave address (hardware selectable by A0, A1, and A2 pins), a single 8-bit control register is written to or read from to determine the selected channels.

The TCA9548A-Q1 may also be used for voltage translation, allowing the use of different bus voltages on each SCn/SDn pair such that 1.8-V, 2.5-V, or 3.3-V parts can communicate with 5-V parts. This is achieved by using external pull-up resistors to pull the bus up to the desired voltage for the master and each slave channel.

8.2 Functional Block Diagram
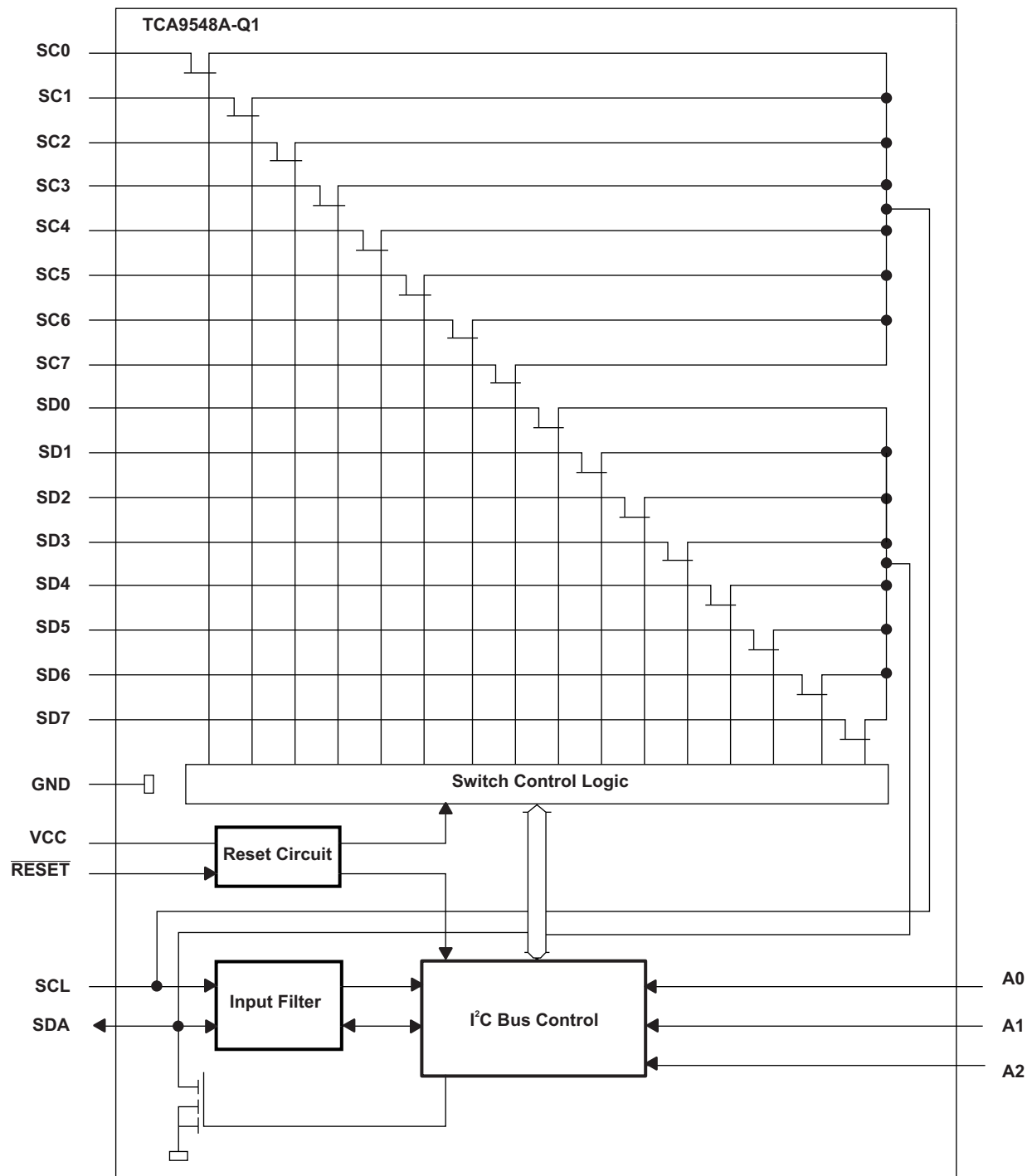
8.3 Feature Description

The TCA9548A-Q1 is an 8-channel, bidirectional translating switch for I²C buses that supports Standard-Mode (100 kHz) and Fast-Mode (400 kHz) operation. The TCA9548A-Q1 features I²C control using a single 8-bit control register in which each bit controls the enabling and disabling of one of the corresponding 8 switch channels for I²C data flow. Depending on the application, voltage translation of the I²C bus can also be achieved using the TCA9548A-Q1 to allow 1.8-V, 2.5-V, or 3.3-V parts to communicate with 5-V parts. Additionally, in the event that communication on the I²C bus enters a fault state, the TCA9548A-Q1 can be reset to resume normal operation using the $\overline{\text{RESET}}$ pin feature or by a power-on reset which results from cycling power to the device.

8.4 Device Functional Modes

8.4.1 $\overline{\text{RESET}}$ Input

The $\overline{\text{RESET}}$ input is an active-low signal that may be used to recover from a bus-fault condition. When this signal is asserted low for a minimum of t_{WL}, the TCA9548A-Q1 resets its registers and I²C state machine and deselects all channels. The $\overline{\text{RESET}}$ input must be connected to V_{CC} through a pull-up resistor.

8.4.2 Power-On Reset

When power is applied to the VCC pin, an internal power-on reset holds the TCA9548A-Q1 in a reset condition until V_{CC} has reached V_{PORR}. At this point, the reset condition is released, and the TCA9548A-Q1 registers and I²C state machine are initialized to their default states, all zeroes, causing all the channels to be deselected. Thereafter, V_{CC} must be lowered below V_{PORF} to reset the device.

8.5 Programming

8.5.1 I²C Interface

The TCA9548A-Q1 has a standard bidirectional I²C interface that is controlled by a master device in order to be configured or read the status of this device. Each slave on the I²C bus has a specific device address to differentiate between other slave devices that are on the same I²C bus. Many slave devices require configuration upon startup to set the behavior of the device. This is typically done when the master accesses internal register maps of the slave, which have unique register addresses. A device can have one or multiple registers where data is stored, written, or read.

The physical I²C interface consists of the serial clock (SCL) and serial data (SDA) lines. Both SDA and SCL lines must be connected to V_{CC} through a pull-up resistor. The size of the pull-up resistor is determined by the amount of capacitance on the I²C lines. (For further details, see the *I²C Pull-up Resistor Calculation* application report. Data transfer may be initiated only when the bus is idle. A bus is considered idle if both SDA and SCL lines are high after a STOP condition (See 图 6 and 图 7).

The following is the general procedure for a master to access a slave device:

1. If a master wants to send data to a slave:
   – Master-transmitter sends a START condition and addresses the slave-receiver.
   – Master-transmitter sends data to slave-receiver.
   – Master-transmitter terminates the transfer with a STOP condition.
2. If a master wants to receive or read data from a slave:
   – Master-receiver sends a START condition and addresses the slave-transmitter.
   – Master-receiver sends the requested register to read to slave-transmitter.
   – Master-receiver receives data from the slave-transmitter.

Programming (接下页)

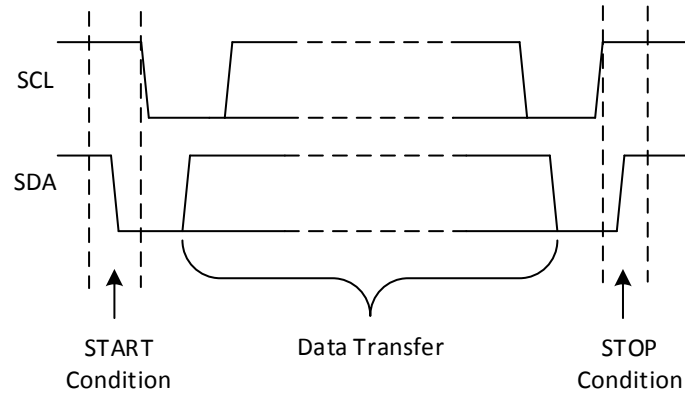– Master-receiver terminates the transfer with a STOP condition.
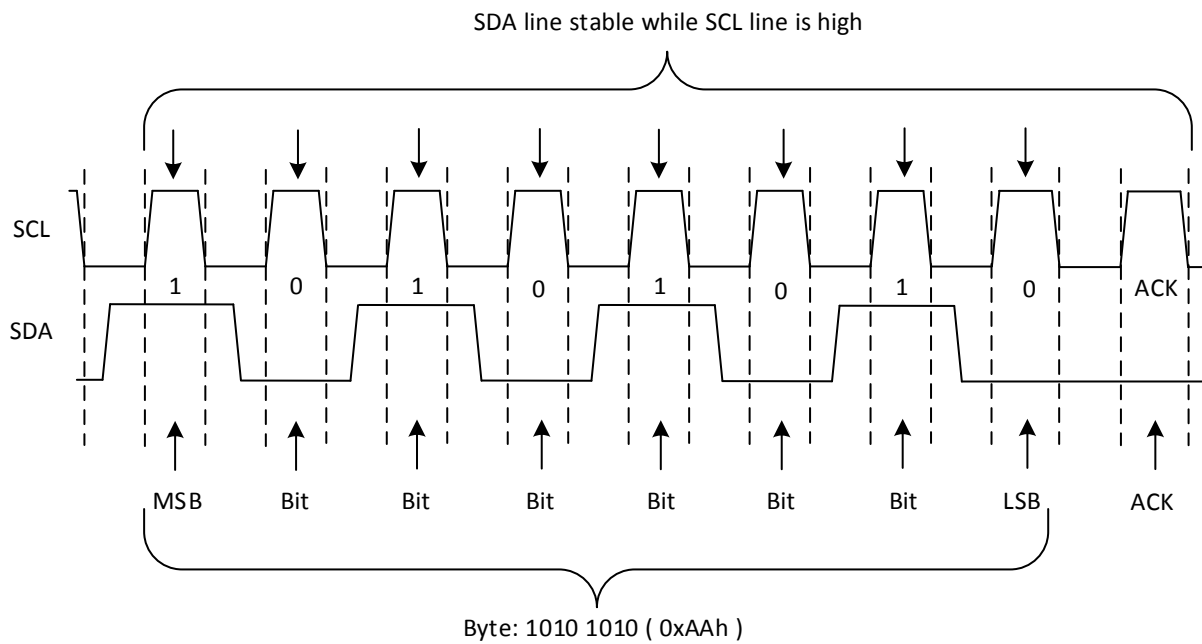
图 6. **Definition of Start and Stop Conditions**

图 7. **Bit Transfer**

8.5.2 Device Address

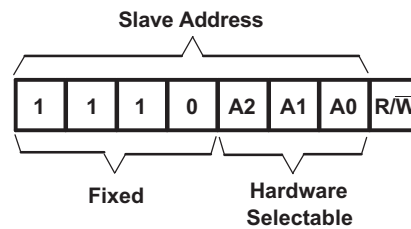图 8 shows the address byte of the TCA9548A-Q1.

图 8. **TCA9548A-Q1 Address**

Programming (接下页)

The last bit of the slave address defines the operation (read or write) to be performed. When it is high (1), a read is selected, while a low (0) selects a write operation.

表 1 shows the TCA9548A-Q1 address reference.

表 1. Address Reference

INPUTS			I^{2}C BUS SLAVE ADDRESS
A2	A1	A0	
L	L	L	112 (decimal), 70 (hexadecimal)
L	L	H	113 (decimal), 71 (hexadecimal)
L	H	L	114 (decimal), 72 (hexadecimal)
L	H	H	115 (decimal), 73 (hexadecimal)
H	L	L	116 (decimal), 74 (hexadecimal)
H	L	H	117 (decimal), 75 (hexadecimal)
H	H	L	118 (decimal), 76 (hexadecimal)
H	H	H	119 (decimal), 77 (hexadecimal)

8.5.3 Bus Transactions

Data must be sent to and received from the slave devices, and this is accomplished by reading from or writing to registers in the slave device.

Registers are locations in the memory of the slave which contain information, whether it be the configuration information or some sampled data to send back to the master. The master must write information to these registers in order to instruct the slave device to perform a task.

While it is common to have registers in I^{2}C slaves, note that not all slave devices have registers. Some devices are simple and contain only 1 register, which may be written to directly by sending the register data immediately after the slave address, instead of addressing a register. The TCA9548A-Q1 is example of a single-register device, which is controlled via I^{2}C commands. Since it has 1 bit to enable or disable a channel, there is only 1 register needed, and the master merely writes the register data after the slave address, skipping the register number.

8.5.3.1 Writes

To write on the I^{2}C bus, the master sends a START condition on the bus with the address of the slave, as well as the last bit (the R/$\overline{W}$ bit) set to 0, which signifies a write. The slave acknowledges, letting the master know it is ready. After this, the master starts sending the control register data to the slave until the master has sent all the data necessary (which is sometimes only a single byte), and the master terminates the transmission with a STOP condition.

There is no limit to the number of bytes sent, but the last byte sent is what is in the register.

图 9 shows an example of writing a single byte to a slave register.

Master controls SDA line

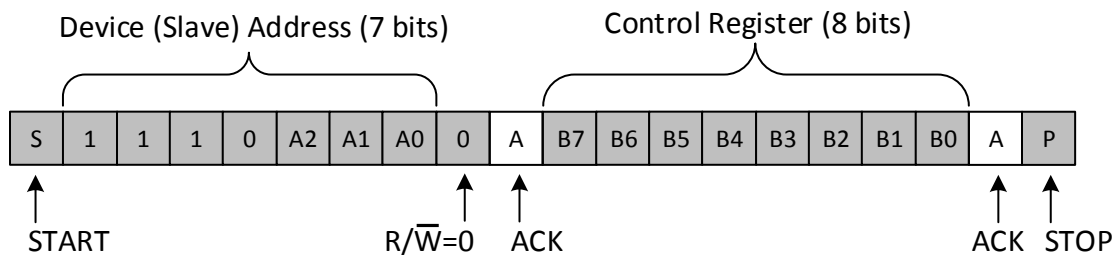Slave controls SDA line

Write to one register in a device

Device (Slave) Address (7 bits)   Control Register (8 bits)

| S | 1 | 1 | 1 | 0 | A2 | A1 | A0 | 0 | A | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | A | P |

START $R/\overline{W}=0$ ACK   ACK STOP

图 9. Write to Register

8.5.3.2 Reads

Reading from a slave is very similar to writing, but the master sends a START condition, followed by the slave address with the $R/\overline{W}$ bit set to 1 (signifying a read). The slave acknowledges the read request, and the master releases the SDA bus but continues supplying the clock to the slave. During this part of the transaction, the master becomes the master-receiver, and the slave becomes the slave-transmitter.

The master continues to send out the clock pulses, but releases the SDA line so that the slave can transmit data. At the end of every byte of data, the master sends an ACK to the slave, letting the slave know that it is ready for more data. Once the master has received the number of bytes it is expecting, it sends a NACK, signaling to the slave to halt communications and release the bus. The master follows this up with a STOP condition.

图 10 shows an example of reading a single byte from a slave register.

Master controls SDA line

Slave controls SDA line

Device (Slave) Address (7 bits)   Control Register (8 bits)

| S | 1 | 1 | 1 | 0 | A2 | A1 | A0 | 1 | A | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | NA | P |

START $R/\overline{W}=1$ ACK   NACK STOP
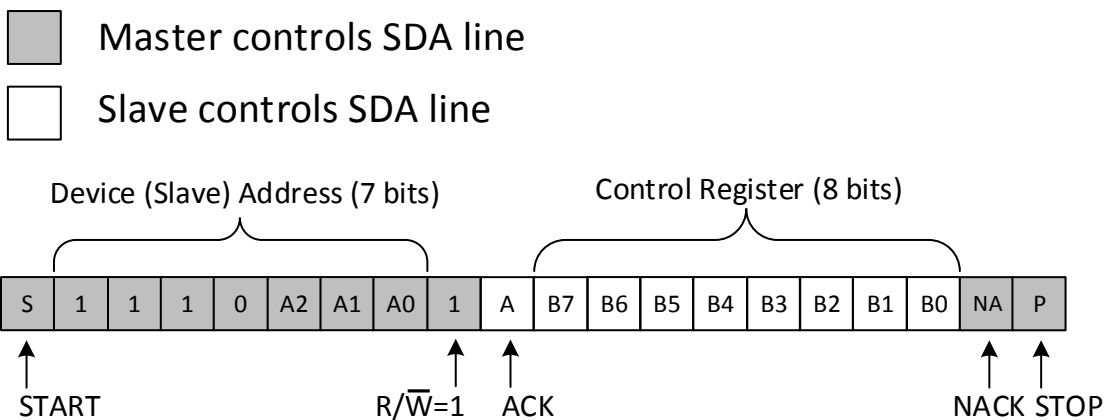
图 10. Read from Control Register

8.5.4 Control Register

Following the successful acknowledgment of the address byte, the bus master sends a command byte that is stored in the control register in the TCA9548A-Q1 (see 图 11). This register can be written and read via the I^{2}C bus. Each bit in the command byte corresponds to a SCn/SDn channel and a high (or 1) selects this channel. Multiple SCn/SDn channels may be selected at the same time. When a channel is selected, the channel becomes active after a stop condition has been placed on the I^{2}C bus. This ensures that all SCn/SDn lines are in a high state when the channel is made active, so that no false conditions are generated at the time of connection. A stop condition always must occur immediately after the acknowledge cycle. If multiple bytes are received by the TCA9548A-Q1, it saves the last byte received.

Channel Selection Bits (Read/Write)
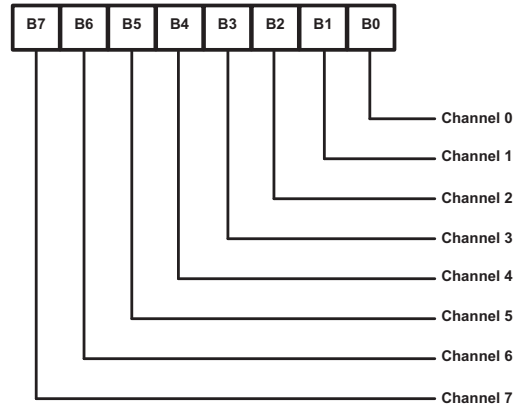
图 11. Control Register

表 2 shows the TCA9548A-Q1 Command Byte Definition.

表 2. Command Byte Definition

CONTROL REGISTER BITS								COMMAND
B7	B6	B5	B4	B3	B2	B1	B0	
X	X	X	X	X	X	X	0	Channel 0 disabled
							1	Channel 0 enabled
X	X	X	X	X	X	0	X	Channel 1 disabled
						1		Channel 1 enabled
X	X	X	X	X	0	X	X	Channel 2 disabled
					1			Channel 2 enabled
X	X	X	X	0	X	X	X	Channel 3 disabled
				1				Channel 3 enabled
X	X	X	0	X	X	X	X	Channel 4 disabled
			1					Channel 4 enabled
X	X	0	X	X	X	X	X	Channel 5 disabled
		1						Channel 5 enabled
X	0	X	X	X	X	X	X	Channel 6 disabled
	1							Channel 6 enabled
0	X	X	X	X	X	X	X	Channel 7 disabled
1								Channel 7 enabled
0	0	0	0	0	0	0	0	No channel selected, power-up/reset default state

8.5.5 $\overline{\text{RESET}}$ Input

The $\overline{\text{RESET}}$ input is an active-low signal that may be used to recover from a bus-fault condition. When this signal is asserted low for a minimum of t_{WL}, the TCA9548A-Q1 resets its registers and I^{2}C state machine and deselects all channels. The $\overline{\text{RESET}}$ input must be connected to V_{CC} through a pull-up resistor.

8.5.6 Power-On Reset

When power (from 0 V) is applied to V_{CC}, an internal power-on reset holds the TCA9548A-Q1 in a reset condition until V_{CC} has reached V_{POR}. At that point, the reset condition is released and the TCA9548A-Q1 registers and I^{2}C state machine initialize to their default states. After that, V_{CC} must be lowered to below V_{POR} and then back up to the operating voltage for a power-reset cycle.

9 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

Applications of the TCA9548A-Q1 contain an I^2C (or SMBus) master device and up to eight I^2C slave devices. The downstream channels are ideally used to resolve I^2C slave address conflicts. For example, if eight identical digital temperature sensors are needed in the application, one sensor can be connected at each channel: 0-7. When the temperature at a specific location needs to be read, the appropriate channel can be enabled and all other channels switched off, the data can be retrieved, and the I^2C master can move on and read the next channel.

In an application where the I^2C bus contains many additional slave devices that do not result in I^2C slave address conflicts, these slave devices can be connected to any desired channel to distribute the total bus capacitance across multiple channels. If multiple switches are enabled simultaneously, additional design requirements must be considered (see the *Design Requirements* section and *Detailed Design Procedure* section).

9.2 Typical Application

图 12 shows an application in which the TCA9548A-Q1 can be used.

Typical Application (接下页)
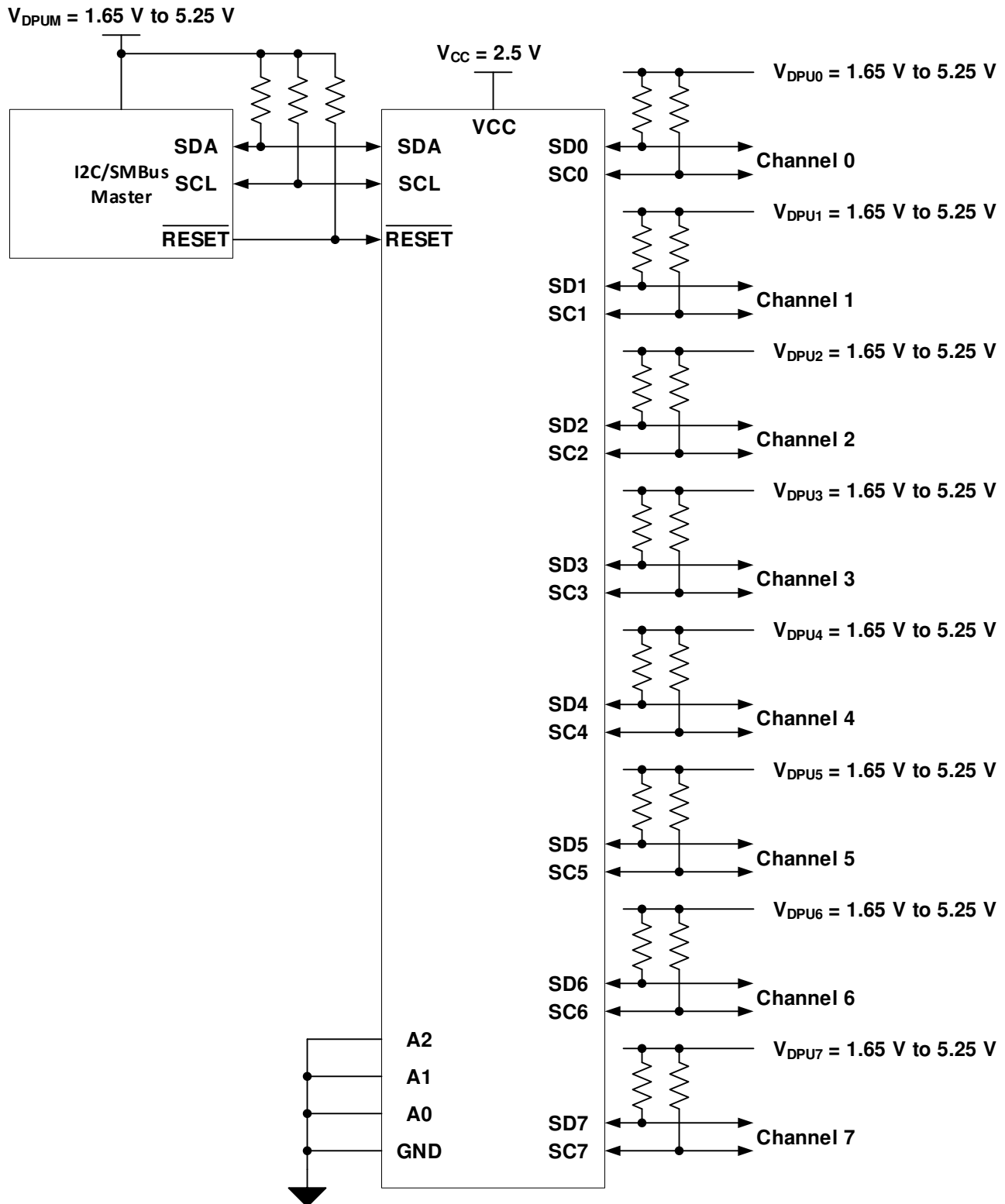
图 12. **Typical Application Schematic**

Typical Application (接下页)

9.2.1 Design Requirements

A typical application of the TCA9548A-Q1 contains one or more data pull-up voltages, V_{DPUX}, one for the master device (V_{DPUM}) and one for each of the selectable slave channels ($V_{DPU0} - V_{DPU7}$). In the event where the master device and all slave devices operate at the same voltage, then $V_{DPUM} = V_{DPUX} = VCC$. In an application where voltage translation is necessary, additional design requirements must be considered to determine an appropriate V_{CC} voltage.

The A0, A1, and A2 pins are hardware selectable to control the slave address of the TCA9548A-Q1. These pins may be tied directly to GND or V_{CC} in the application.

If multiple slave channels are activated simultaneously in the application, then the total I_{OL} from SCL/SDA to GND on the master side is the sum of the currents through all pull-up resistors, R_p.

The pass-gate transistors of the TCA9548A-Q1 are constructed such that the V_{CC} voltage can be used to limit the maximum voltage that is passed from one I²C bus to another.

图 13 shows the voltage characteristics of the pass-gate transistors (note that the graph was generated using data specified in the *Electrical Characteristics* table). In order for the TCA9548A-Q1 to act as a voltage translator, the V_{pass} voltage must be equal to or lower than the lowest bus voltage. For example, if the main bus is running at 5 V and the downstream buses are 3.3 V and 2.7 V, V_{pass} must be equal to or below 2.7 V to effectively clamp the downstream bus voltages. As shown in 图 13, $V_{pass(max)}$ is 2.7 V when the TCA9548A-Q1 supply voltage is 4 V or lower, so the TCA9548A-Q1 supply voltage could be set to 3.3 V. Pull-up resistors then can be used to bring the bus voltages to their appropriate levels (see 图 12).

9.2.2 Detailed Design Procedure

Once all the slaves are assigned to the appropriate slave channels and bus voltages are identified, the pull-up resistors, R_p, for each of the buses need to be selected appropriately. The minimum pull-up resistance is a function of V_{DPUX}, $V_{OL,(max)}$, and I_{OL} as shown in 公式 1:

$$R_{p(min)} = \frac{V_{DPUX} - V_{OL(max)}}{I_{OL}}$$
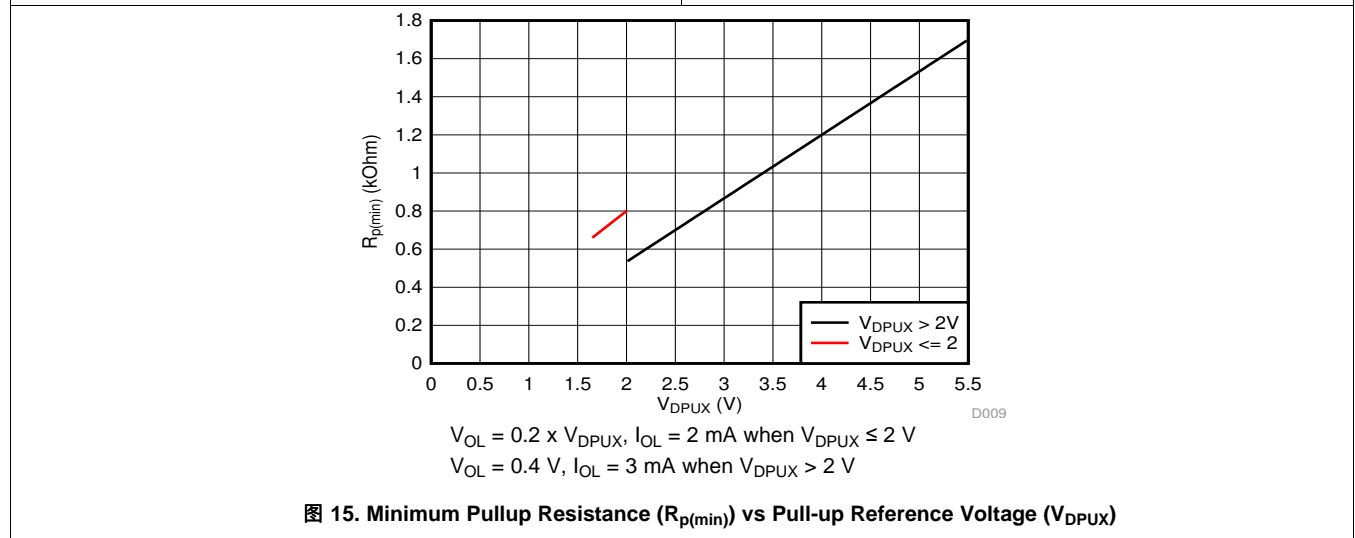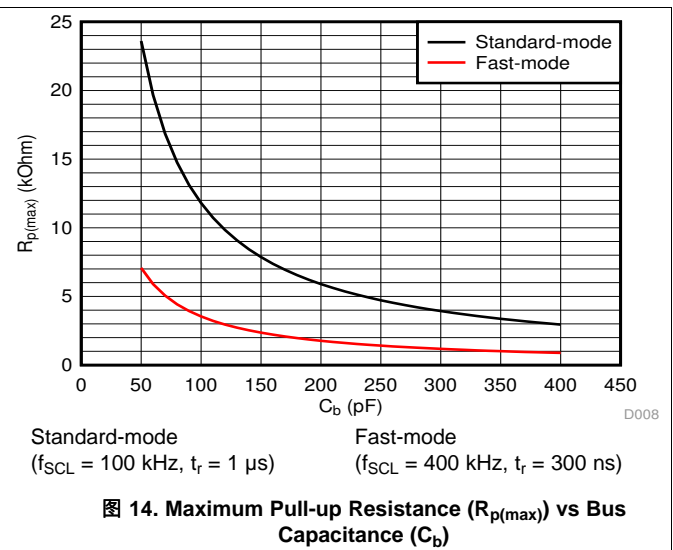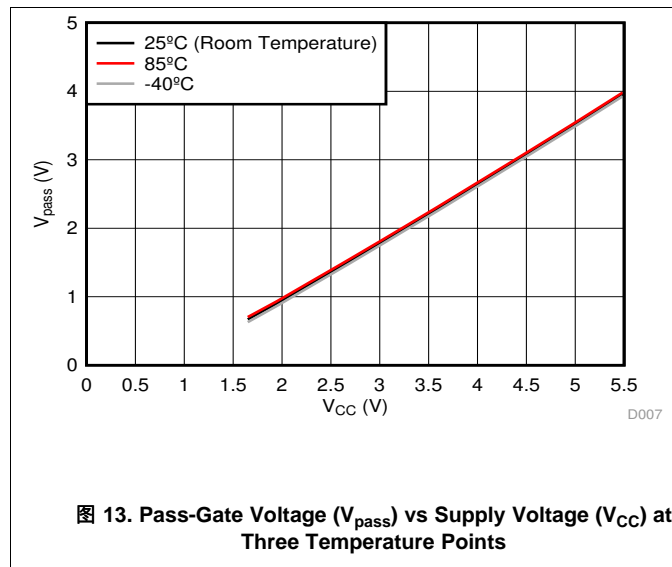
(1)

The maximum pull-up resistance is a function of the maximum rise time, t_r (300 ns for fast-mode operation, $f_{SCL} = 400$ kHz) and bus capacitance, C_b as shown in 公式 2:

$$R_{p(max)} = \frac{t_r}{0.8473 \times C_b}$$

(2)

The maximum bus capacitance for an I²C bus must not exceed 400 pF for fast-mode operation. The bus capacitance can be approximated by adding the capacitance of the TCA9548A-Q1, $C_{io(OFF)}$, the capacitance of wires, connections and traces, and the capacitance of each individual slave on a given channel. If multiple channels are activated simultaneously, each of the slaves on all channels contribute to total bus capacitance.

Typical Application (接下页)

9.2.3 Application Curves

图 13. Pass-Gate Voltage (V_{pass}) vs Supply Voltage (V_{CC}) at Three Temperature Points

Standard-mode
(f_{SCL} = 100 kHz, t_r = 1 μs)

Fast-mode
(f_{SCL} = 400 kHz, t_r = 300 ns)

图 14. Maximum Pull-up Resistance ($R_{p(max)}$) vs Bus Capacitance (C_b)

V_{OL} = 0.2 x V_{DPUX}, I_{OL} = 2 mA when V_{DPUX} ≤ 2 V
V_{OL} = 0.4 V, I_{OL} = 3 mA when V_{DPUX} > 2 V

图 15. Minimum Pullup Resistance ($R_{p(min)}$) vs Pull-up Reference Voltage (V_{DPUX})

10 Power Supply Recommendations

The operating power-supply voltage range of the TCA9548A-Q1 is 1.65 V to 5.25 V applied at the VCC pin. When the TCA9548A-Q1 is powered on for the first time or anytime the device must be reset by cycling the power supply, the power-on reset requirements must be followed to ensure the I^{2}C bus logic is initialized properly.

10.1 Power-On Reset Requirements

In the event of a glitch or data corruption, TCA9548A-Q1 can be reset to its default conditions by using the power-on reset feature. Power-on reset requires that the device go through a power cycle to be completely reset. This reset also happens when the device is powered on for the first time in an application.

A power-on reset is shown in 图 16.

V$_{CC}$ is Lowered Below the POR Threshold, Then Ramped Back Up to V$_{CC}$
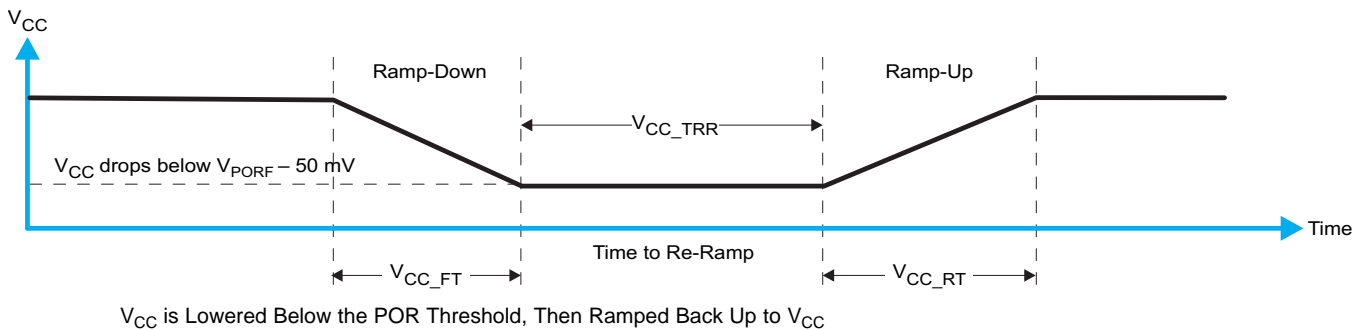
图 16. Power-On Reset Waveform

表 3 specifies the performance of the power-on reset feature for TCA9548A-Q1 for both types of power-on reset.

表 3. Recommended Supply Sequencing and Ramp Rates[1]

PARAMETER			MIN	MAX	UNIT
V$_{CC\_FT}$	Fall time	See 图 16	1	100	ms
V$_{CC\_RT}$	Rise time	See 图 16	0.1	100	ms
V$_{CC\_TRR}$	Time to re-ramp (when V$_{CC}$ drops below V$_{PORF(min)}$ − 50 mV or when V$_{CC}$ drops to GND)	See 图 16	40		µs
V$_{CC\_GH}$	Level that V$_{CC}$ can glitch down to, but not cause a functional disruption when V$_{CC\_GW}$ = 1 µs	See 图 17		1.2	V
V$_{CC\_GW}$	Glitch width that does not cause a functional disruption when V$_{CC\_GH}$ = 0.5 × V$_{CC}$	See 图 17		10	µs

(1) All supply sequencing and ramp rate values are measured at T$_A$ = 25°C

Glitches in the power supply can also affect the power-on reset performance of this device. The glitch width (V$_{CC\_GW}$) and height (V$_{CC\_GH}$) are dependent on each other. The bypass capacitance, source impedance, and device impedance are factors that affect power-on reset performance. 图 17 and 表 3 provide more information on how to measure these specifications.
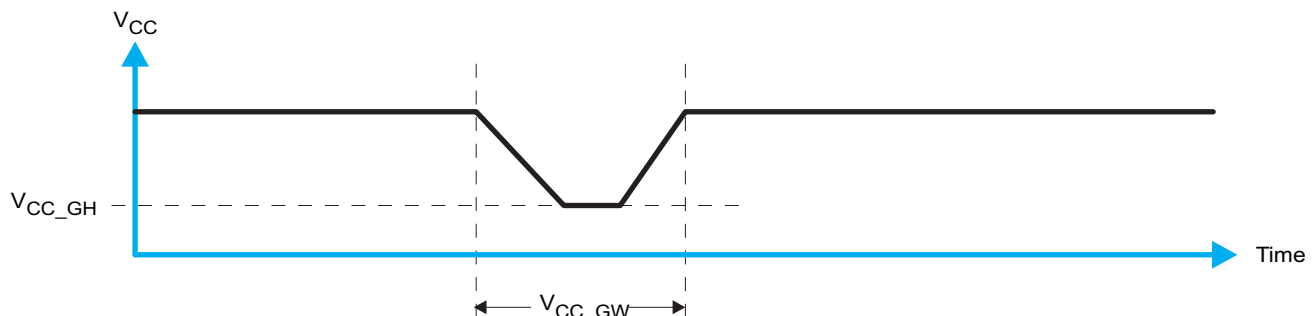

图 17. Glitch Width and Glitch Height

V_{POR} is critical to the power-on reset. V_{POR} is the voltage level at which the reset condition is released and all the registers and the I²C/SMBus state machine are initialized to their default states. The value of V_{POR} differs based on the V_{CC} being lowered to or from 0. 图 18 and 表 3 provide more details on this specification.
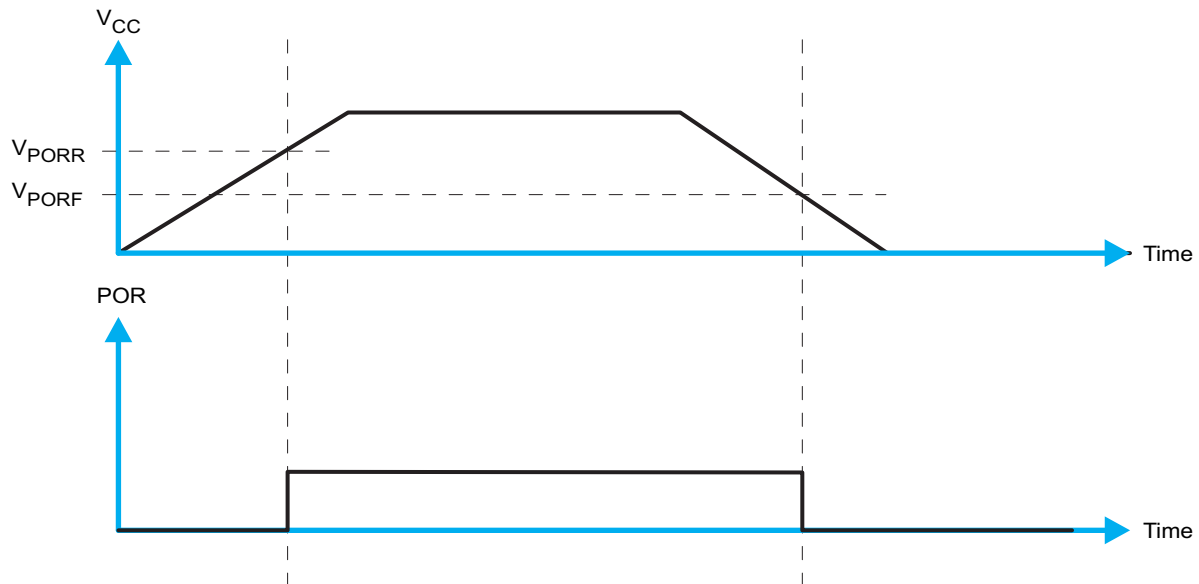

图 18. V_{POR} Example

11 Layout

11.1 Layout Guidelines

For PCB layout of the TCA9548A-Q1, common PCB layout practices must be followed but additional concerns related to high-speed data transfer such as matched impedances and differential pairs are not a concern for I^{2}C signal speeds. It is common to have a dedicated ground plane on an inner layer of the board and pins that are connected to ground must have a low-impedance path to the ground plane in the form of wide polygon pours and multiple vias. Bypass and decoupling capacitors are commonly used to control the voltage on the VCC pin, using a larger capacitor to provide additional power in the event of a short power supply glitch and a smaller capacitor to filter out high-frequency ripple.

In an application where voltage translation is not required, all V_{DPUX} voltages and V_{CC} could be at the same potential and a single copper plane could connect all of the pull-up resistors to the appropriate reference voltage. In an application where voltage translation is required, V_{DPUM} and $V_{DPU0} - V_{DPU7}$, may all be on the same layer of the board with split planes to isolate different voltage potentials.

To reduce the total I^{2}C bus capacitance added by PCB parasitics, data lines (SCn and SDn) must be a short as possible and the widths of the traces must also be minimized (for example, 5-10 mils depending on copper weight).

11.2 Layout Example
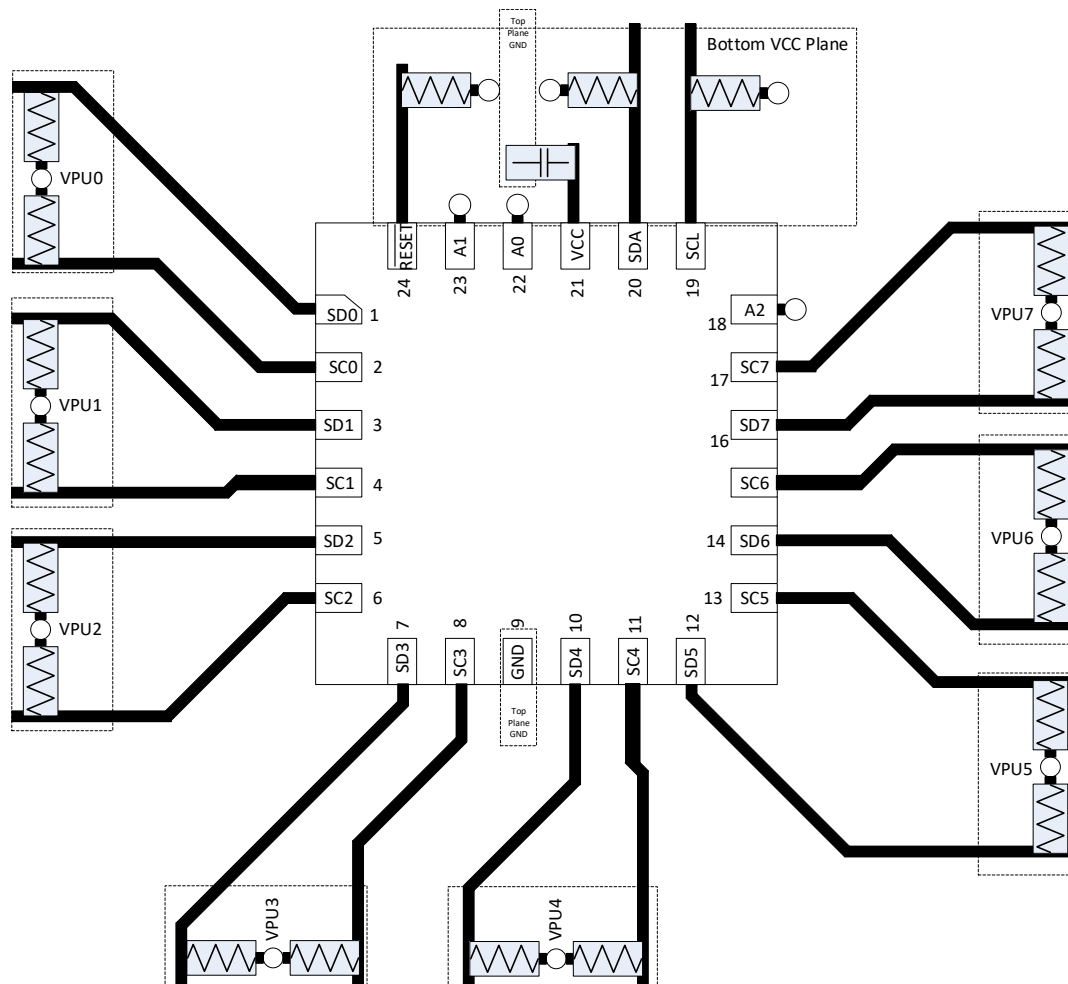
图 19. **Layout Schematic**

12 器件和文档支持

12.1 文档支持

12.1.1 相关文档

请参阅如下相关文档：
- *《I2C 总线上拉电阻计算》*
- *《I2C 总线在采用中继器时的最高时钟频率》*
- *《逻辑器件简介》*
- *《理解 I2C 总线》*
- *《为新设计挑选合适的 I2C 器件》*
- *《TCA9548AEVM 用户指南》*

12.2 接收文档更新通知

要接收文档更新通知，请导航至 TI.com.cn 上的器件产品文件夹。单击右上角的*通知我*进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

12.3 支持资源

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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12.4 商标

E2E is a trademark of Texas Instruments.

12.5 静电放电警告

ESD 可能会损坏该集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理措施和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。 精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

12.6 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更，恕不另行通知，且不会对此文档进行修订。如需获取此数据表的浏览器版本，请查阅左侧的导航栏。

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TCA9548ARGERQ1	ACTIVE	VQFN	RGE	24	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	T9548A	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
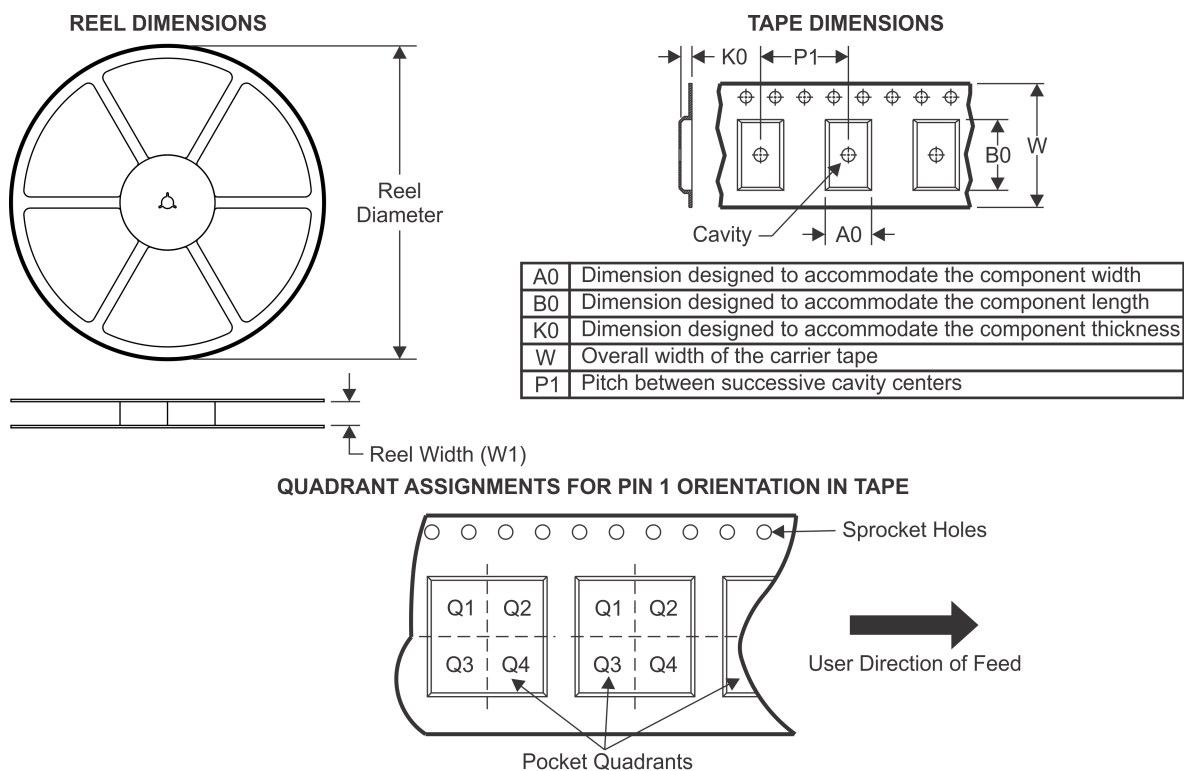
(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TAPE DIMENSIONS

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TCA9548ARGERQ1	VQFN	RGE	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS
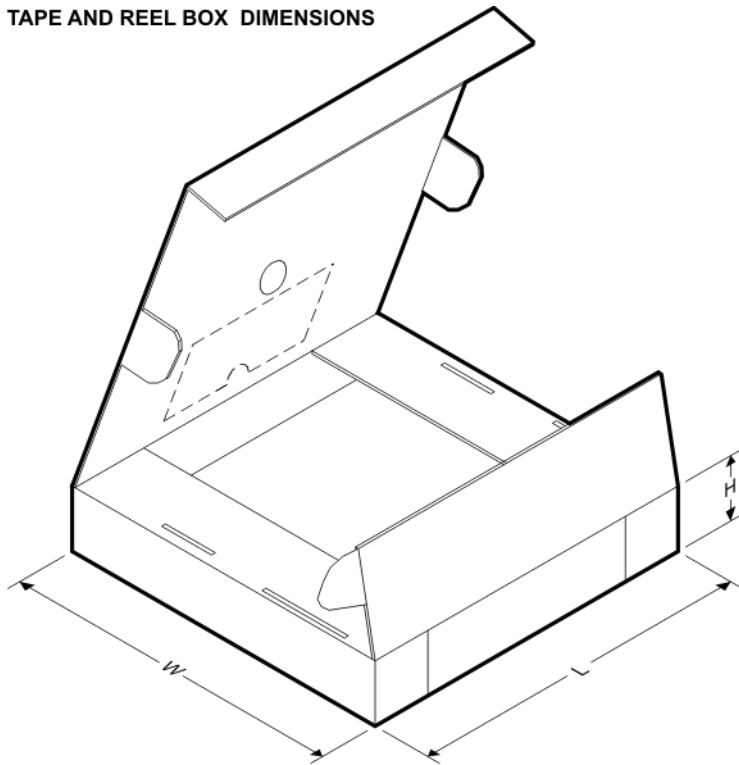
*All dimensions are nominal

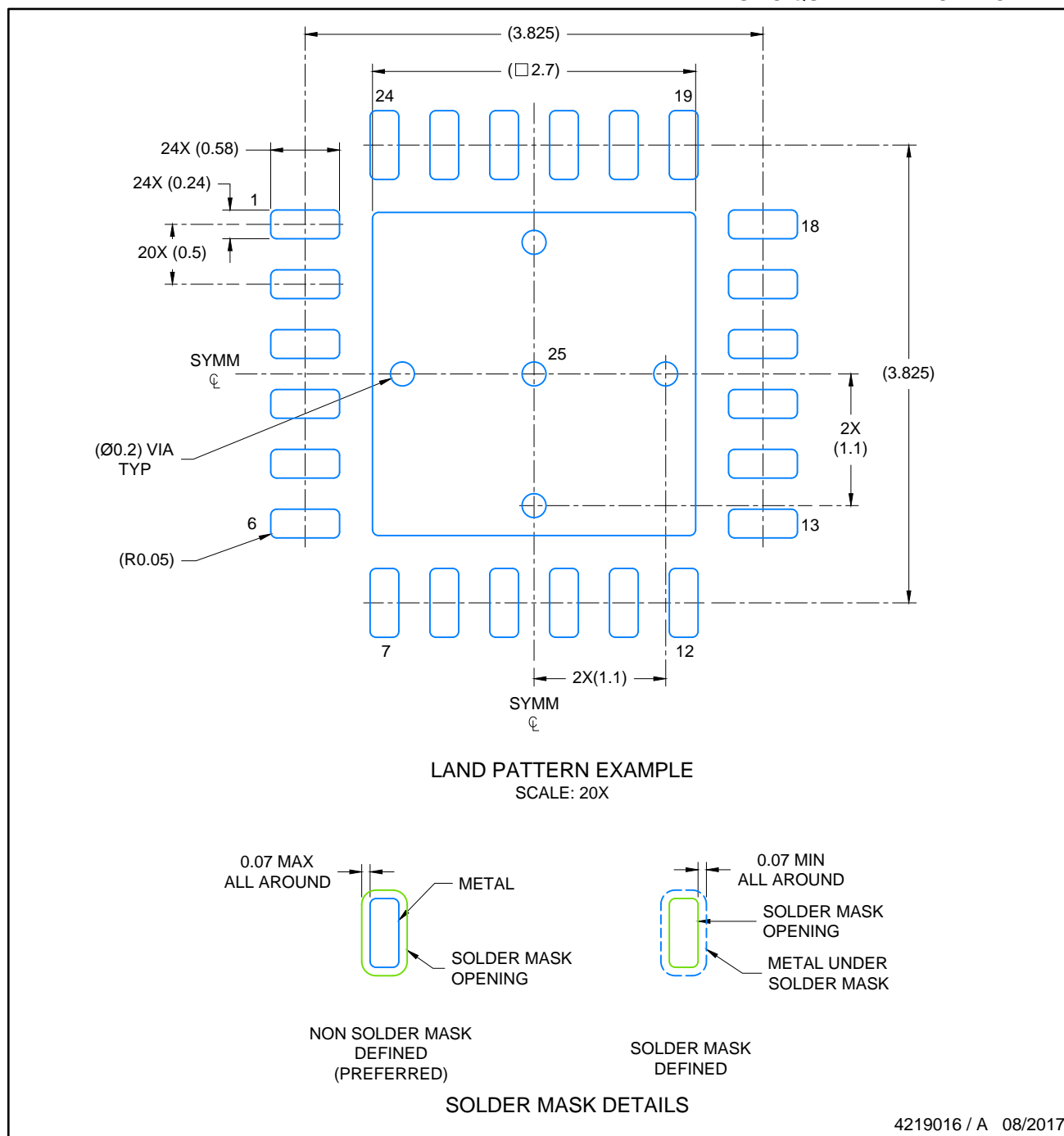| Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TCA9548ARGERQ1	VQFN	RGE	24	3000	367.0	367.0	35.0
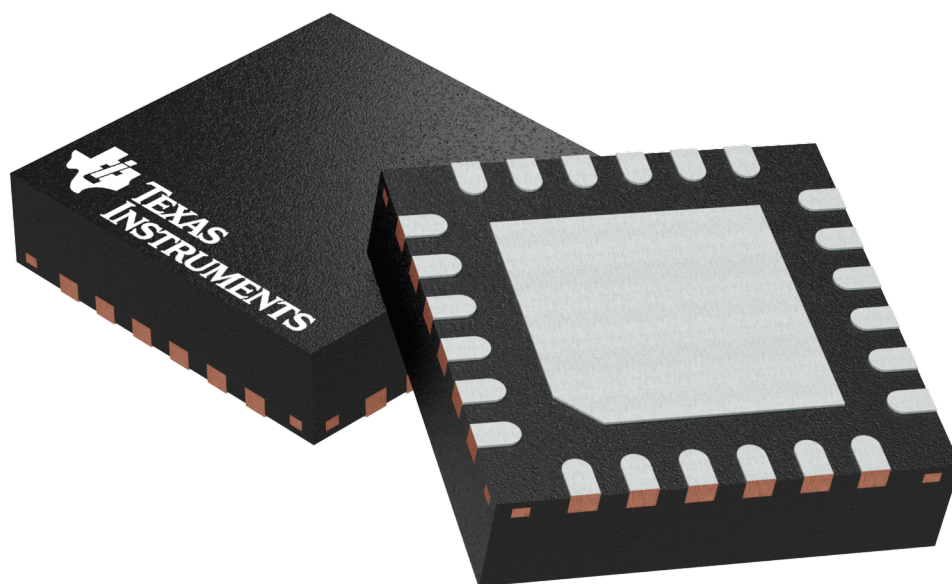
Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4204104/H

B ↔ A

4.1
3.9

PIN 1 INDEX AREA

4.1
3.9

1 MAX

0.05
0.00

C

SEATING PLANE

0.08 C

□ 2.7±0.1

2X 2.5

(0.2) TYP

7   12

20X 0.5

6

13

2X
2.5

25

SYMM
℄

1

18

PIN 1 ID
(OPTIONAL)

24X 0.30
0.18

24   19

SYMM
℄

24X 0.48
0.28

⊕ 0.1 Ⓜ C A B
  0.05 Ⓜ C

4219016 / A   08/2017
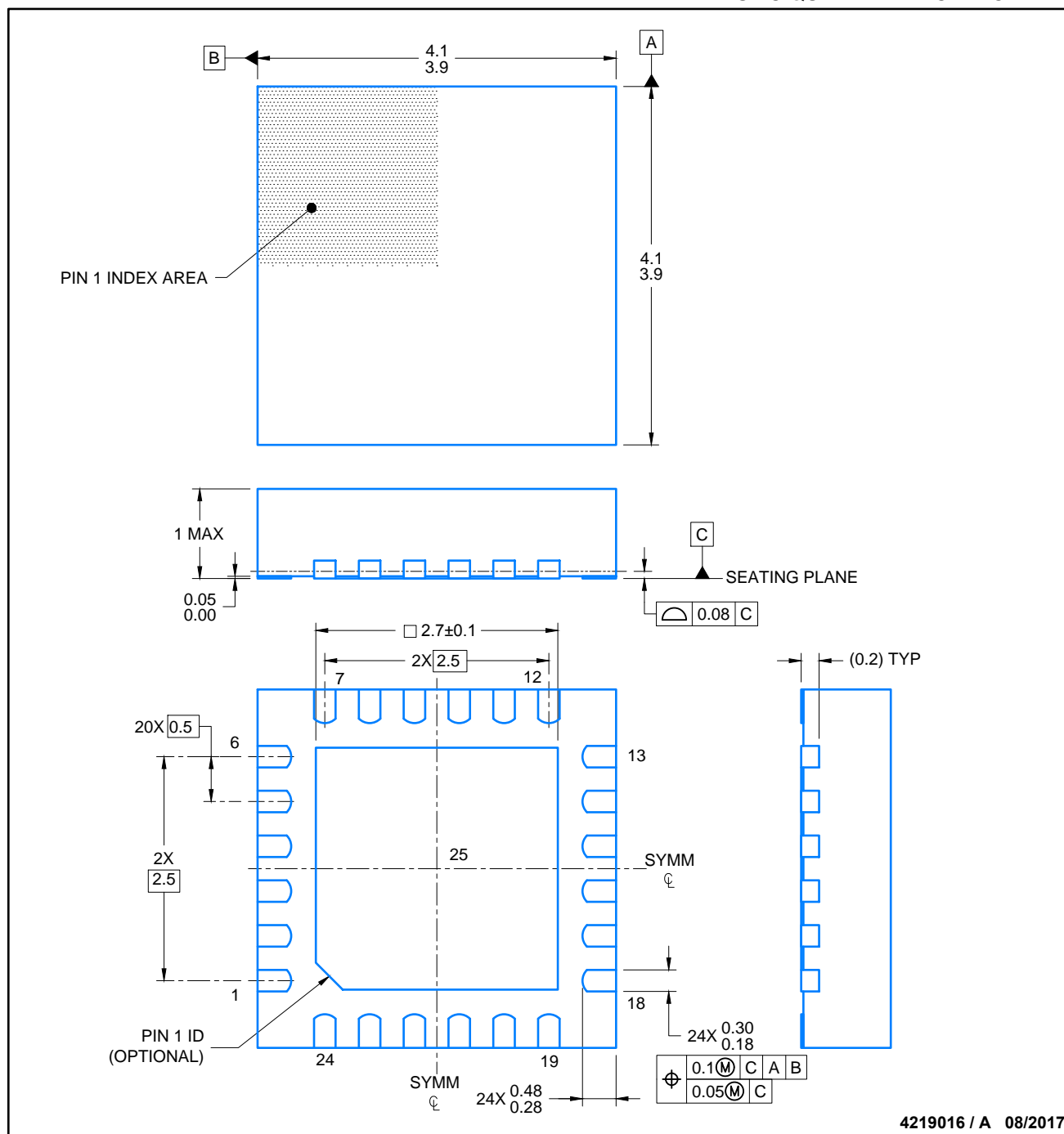
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

(3.825)

(□2.7)

24

19

24X (0.58)

24X (0.24)

1

20X (0.5)

SYMM
℄

(Ø0.2) VIA
TYP

25

(3.825)

2X
(1.1)

18

13

6

(R0.05)

7

12

2X(1.1)

SYMM
℄

LAND PATTERN EXAMPLE
SCALE: 20X

0.07 MAX
ALL AROUND

METAL

SOLDER MASK
OPENING

NON SOLDER MASK
DEFINED
(PREFERRED)

0.07 MIN
ALL AROUND

SOLDER MASK
OPENING

METAL UNDER
SOLDER MASK

SOLDER MASK
DEFINED

SOLDER MASK DETAILS

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NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
78% PRINTED COVERAGE BY AREA
SCALE: 20X

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NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations..

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